

Generating I-V Curves with the Agilent E4360A Solar Array Simulator Using the Parameters V*oc*, I*sc*, N, and R*s*

Application Note



Agilent's family of solar array simulators, including the E435XB Series and E4360A modular solar array simulator mainframe, can be programmed to simulate a wide range of solar array performances. Three methods for generating an I-V curve are available: using table mode to enter I-V data pairs and using parametric values in SAS and list modes.

Two major formats for parametrically programming solar array simulators using equation-based I-V curve generation are currently in use. The parameters required by the equipment using either format are not directly compatible with the other, and the conversion from one format to the other is not mathematically tenable since no closed-form solutions for the equations exist. However, values for V*oc*, V*mp*, I*mp*, and I*sc*, the Agilent format, can be obtained from the values for V*oc*, I*sc*, N, and R*s* through the application of an iterative solution technique. This application note provides the methodology.



Parametric Equations Both parametric formats require the entry of values for the open circuit voltage, V*oc*, and the short circuit current, I*sc*. The additional parameters required by the Agilent E435XB series or E4360A are the maximum power point voltage, V*mp*, and the maximum power point current, I*mp*. Additional parameters required by the other format are values for N, which is strongly related to the array shunt resistance, and R*s*, which is essentially the output resistance of the array.

> In Figure 1, the slope of the "horizontal" part of the I-V curve is a strong function of N, and the "vertical" section is a strong function of R*s*. Iteratively calculable values of I*mp* and V*mp* are a function of N and R*s* and will generate an identical I-V curve.



In SAS and List modes the E4360A accepts four parameters, V*oc*, V*mp*, I*mp*, and I*sc*, that are applied to internal equations to simulate an I-V curve. The equations are:

$$
V_{OC} * \ln \left[2 - \left(\frac{I}{I_{SC}}\right)^N\right]
$$
  

$$
V = \frac{\ln(2)}{\ln(2)} - R_s * (I - I_{SC})
$$
  

$$
\left(1 + \frac{R_s * I_{SC}}{V_{OC}}\right)
$$

Values for R*s* and N are derived from the following:

EQUATION 2  
\n
$$
R_S = \frac{V_{oc} - V_{mp}}{I_{mp}}
$$
\nEQUATION 3  
\n
$$
N = \frac{\ln(2 \cdot 2^a)}{\ln(\frac{I_{mp}}{I_{eq}})}
$$

EQUATION 4

$$
a = \frac{\text{V}_{mp} * (1 + \text{R}_s * \frac{\text{I}_{sc}}{\text{V}_{oc}}) + \text{R}_s * (1_{mp} - \text{I}_{sc})}{\text{V}_{oc}}
$$

**FIGURE 1.** 

*Array I-V curve relationship of Rs, N, and Imp, Vmp.* 

*Decreasing N and increasing Rs results in decreasing Imp and Vmp.*

\* The exponential model is described in the **EQUATION 15 ID** *paper: Britton, Lunscher, and Tanju, "A 9KW High-Performance Solar Array Simulator", Proceedings of the European Space Power Conference, August 1993 (ESA WPP-054, August 1993)* 

### Problem

Solution

Values for V*mp* and I*mp* are not directly calculable with the governing transcendental equations. If you are familiar with the parameters V*oc*, I*sc*, R*s*, and N and prefer to start with them when you work with your Agilent E435XB Series solar array simulator or E4360A solar array simulator system, you must have an accurate, convenient, and fast conversion method. You must be able to obtain values for V*mp* and I*mp* that when coupled with V*oc* and I*sc* result in I-V curves that are identical to those generated by the N and R*s* format.

Obtaining values for V*mp* and I*mp* begins with manipulating equations 2 and 4 to obtain a new expression for equation 4 that replaces V*mp* with I*mp*. That is accomplished by substituting for the variable V*mp* in equation 4 with the expression for V*mp* derived from equation 2. The equation for N is then iteratively solved until its calculated value equals the value of N given as a part of the V*oc*, I*sc*, R*s* and N parameter list. Starting with an initial value for I*mp* and then incrementing I*mp* positively or negatively until the calculated value for N equals the given value of N establishes I*mp*. V*mp* may then be calculated with equation 2. The process can of course be done manually, but can be very time consuming. Achieving quick and accurate results can be done with a computer program or a spreadsheet-embedded macro.

**Process** 

Solving equation 2 for V*mp* results in:

EQUATION 5

$$
V_{mp} = V_{oc} - R_s * I_{mp}
$$

Substituting equation 5 in the equation for  $\alpha$  (equation 4) results in equation 6.

EQUATION 6

$$
a = \frac{(V_{oc} - R_s * I_{mp}) * (1 + R_s * \frac{I_{sc}}{V_{oc}}) + R_s * (I_{mp} - I_{sc})}{V_{oc}}
$$

Given V*oc*, I*sc*, R*s*, and N, equations 6 and 3 are iteratively solved for a and N respectively with an initial value for I*mp* (equal to one half of I*sc*) that is thereafter incremented (increased and/or decreased) until the calculated value for N is within an acceptable error band relative to the given value of N. The magnitude of the error band determines the degree to which the calculated values of V*mp* and I*mp* will result in an equivalent curve generated by the R*s* and N values. The magnitude of the error band influences the number of iterations required to establish a value for I*mp*. The tighter the error band the better the curve match and the greater the number of required iterations.

The calculation of the value of  $\alpha$  is maintained as an intermediate step as it must be checked to ensure that it is not greater than or equal to 1, or less than or equal to zero before calculating the value of N. A value of 1 would result in an attempt to calculate the natural log of zero in equation 3; a calculated solution for N does not exist. Values for  $\alpha$  less than or equal to zero or greater than 1 will result in useless calculated values for N.

# Conversion Algorithm An example algorithm follows.

Set allowable error limit for exit criteria. This establishes the allowable error limit for the calculated value of N relative to the given value of N.

N error =  $N$  given\*1E-12

Set values for calculating initial Imp

 $left = 0$  $right =$   $Isc$ 

Execute the following loop until the calculated value for N defined as N\_calc is within the error limit N error or until  $a \le 0$  or  $a \Rightarrow 1$ .

#### Do

 $Imp = (left + right) / 2$  $a = ((Voc - Rs * Imp) * (1 + Rs * lsc / Voc) + Rs * (Imp - lsc)) / Voc)$ If  $a \leq 1$  Then N calc =  $Log(2 - 2^{\wedge} a) / Log(Imp / lsc)$  If N\_calc > N\_given Then  $right = Imp$ ElseIf N\_calc  $\leq N$  given Then  $left = Imp$  End If End If Loop Until Abs( $N_{cal}$ calc –  $N_{g}$ iven) <=  $N_{\text{error}}$  Or a >= 1 Or a <= 0 If a > 0 And a < 1 And Abs(N\_calc – N\_given) <= N\_error Then  $Vmp = Voc - Rs * Imp$ 

 If the do loop is exited here, the calculated value for Imp is used to calculate Vmp. Imp and Vmp are now established

### Else

 If the do loop is exited here with a not greater than zero or less than 1, Vmp and Imp are not calculable with this algorithm.

### End If

## Additional Resources

An R*s* and N to V*mp* and I*mp* macro embedded spreadsheet conversion tool is available. The following graphic is an illustration of the "Conversion from R*s* and N to V*mp* and I*mp*" tool available on the Agilent application note Web site. Entering values for V*oc*, I*sc*, R*s*, and N in the spreadsheet and clicking the Solve for V*mp* and I*mp* button will calculate and return values in the designated fields.

To ensure that the values of I*mp* and V*mp* will accurately reproduce and represent the I-V curve that would be generated by the use of R*s* and N, the maximum allowable error in the calculation of N is limited to 1e-12 times the given value of N.



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